

Notice of References Cited

Application/Control No.

09/915,554

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

JOHN J. LEE

Art Unit

2618

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,359,901	03-2002	Todd et al.	370/465
*	B	US-6,683,886	01-2004	van der Tuijn et al.	370/458
*	C	US-6,940,831	09-2005	Omi et al.	370/310.1
*	D	US-2002/0089963	07-2002	Kang et al.	370/340
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.